Power MOSFET

30 V, 30 A, Single N-Channel, SO-8 FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Device

Applications

- Refer to Application Note AND8195/D
- CPU Power Delivery
- DC-DC Converters
- High Side Switching

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

Parameter Symbol Value Unit						
Para	Parameter			Value	Unit	
Drain-to-Source Volt	age		V_{DSS}	30	V	
Gate-to-Source Voltage			V_{GS}	±20	V	
Continuous Drain		T _A = 25°C	Ι _D	10.8	Α	
Current R _{0JA} (Note 1)		T _A = 85°C		7.8		
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.1	W	
Continuous Drain		T _A = 25°C	I _D	17.4	Α	
Current R _{θJA} ≤ 10 sec		T _A = 85°C		12.5		
Power Dissipation $R_{\theta JA,} t \leq 10 \text{ sec}$	Steady	T _A = 25°C	P _D	5.43	W	
Continuous Drain	State	State $T_A = 25^{\circ}C$ I_D		6.9	Α	
Current R _{θJA} (Note 2)		T _A = 85°C		5.0		
Power Dissipation R _{θJA} (Note 2)		T _A = 25°C	P _D	0.86	W	
Continuous Drain		T _C = 25°C	I _D	30	Α	
Current R _{θJC} (Note 1)		T _C = 85°C		22		
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	32.5	W	
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	85	Α	
Current limited by pac	Current limited by package T _A = 25°C			90	Α	
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to +150	°C	
Source Current (Body Diode)			I _S	32.5	Α	
Drain to Source dV/dt			dV/dt	6.0	V/ns	
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 50 V, V_{GS} = 10 V, I_{L} = 24 A_{pk} , L = 0.1 mH, R_{G} = 25 Ω)			EAS	28.8	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C	

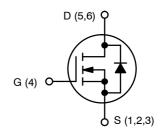
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



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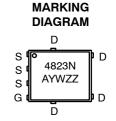
http://onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
30 V	10.5 m Ω @ 10 V	30 A	
30 V	18.0 m Ω @ 4.5 V	30 A	



N-CHANNEL MOSFET





A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4823NT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NTMFS4823NT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	3.8	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	59.4	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	146	C/VV
Junction-to-Ambient - t ≤ 10 sec	$R_{ heta JA}$	23	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

FI FCTRICAL CHARACTERISTICS (T = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•			•		•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				24		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25 °C			1.0	
			T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	; = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.5	1.9	2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.1		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V to 11.5 V	I _D = 30 A		9.2	10.6	mΩ
			I _D = 15 A		9.1		
		V _{GS} = 4.5 V	I _D = 30 A		15.6	18.0	
			I _D = 15 A		15.1		
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D = 15 A			26		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				795		
Output Capacitance	Coss	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			163		pF
Reverse Transfer Capacitance	C _{RSS}				85		
Total Gate Charge	Q _{G(TOT)}				6.0	11	
Threshold Gate Charge	Q _{G(TH)}	45.4.74	45.771 00.4		1.0]
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$			2.6		nC
Gate-to-Drain Charge	Q_{GD}				2.5		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 11.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_D = 30 \text{ A}$			13		nC
SWITCHING CHARACTERISTICS (Note 4)	-			-		-	•
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			10.8		
Rise Time	t _r				29		
Turn-Off Delay Time	t _{d(OFF)}				12.7		ns
Fall Time	t _f				3.8		1

- 3. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%. 4. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 4)						
Turn-On Delay Time	t _{d(ON)}	V _{GS} = 11.5 V, V _{DS} = 15 V,			6.65		
Rise Time	t _r				15.3		
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 15 A, R_G$	= 3.0 Ω		17.6		ns
Fall Time	t _f	1			3.0		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	T _J = 25°C		0.95	1.2	.,
			T _J = 125°C		0.8		V
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			7.9		
Charge Time	t _a				5.8		ns
Discharge Time	t _b				2.1		
Reverse Recovery Charge	Q _{RR}				0.6		nC
PACKAGE PARASITIC VALUES				-			
Source Inductance	L _S	T _A = 25°C			1.3		nΗ
Drain Inductance	L _D				0.005		
Gate Inductance	L _G				1.84		
Gate Resistance	R_{G}				1.0	3.0	Ω

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

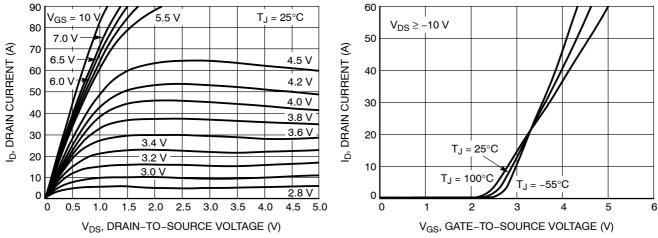


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics

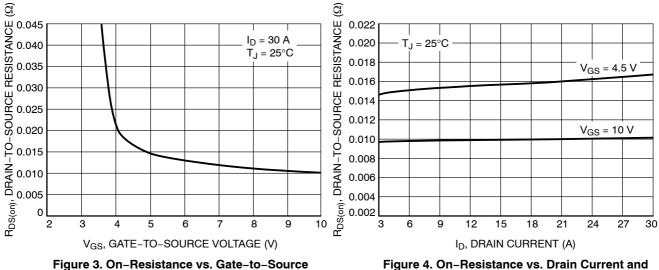


Figure 3. On-Resistance vs. Gate-to-Source Voltage

1.8

1.6

1.4

1.2

0.8

0.6 L -50

-25

I_D = 30 A V_{GS} = 10 V

R_{DS(on)}, DRAIN-TO-SOURCE RES-ISTANCE (NORMALIZED)

1000 V_{GS} = 0 V T_J = 150°C T_J = 100°C T

T_J, JUNCTION TEMPERATURE (°C)

Figure 5. On–Resistance Variation with
Temperature

50

100

Figure 6. Drain-to-Source Leakage Current vs. Voltage

Gate Voltage

TYPICAL CHARACTERISTICS

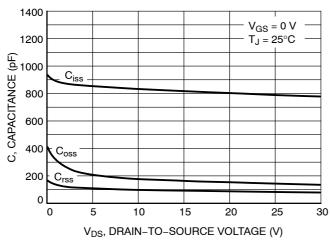


Figure 7. Capacitance Variation

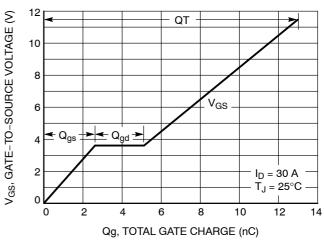


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

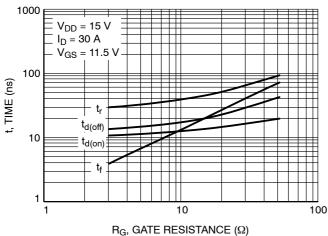


Figure 9. Resistive Switching Time Variation

vs. Gate Resistance

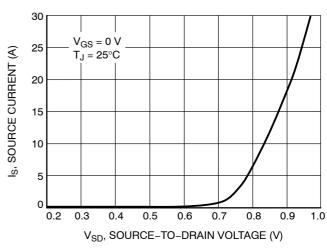


Figure 10. Diode Forward Voltage vs. Current

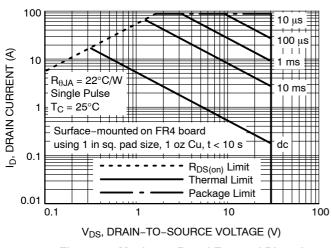


Figure 11. Maximum Rated Forward Biased Safe Operating Area

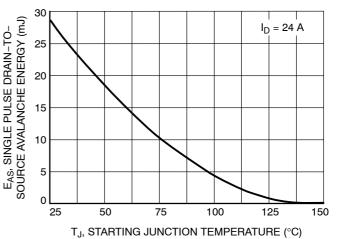
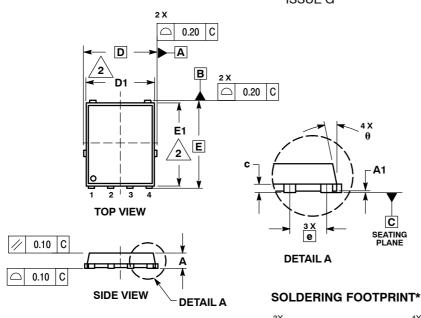


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

PACKAGE DIMENSIONS





NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

	MILLIMETERS						
DIM	MIN	MAX					
Α	0.90	1.00	1.10				
A1	0.00		0.05				
b	0.33	0.41	0.51				
С	0.23	0.28	0.33				
D		5.15 BSC					
D1	4.50	4.90	5.10				
D2	3.50		4.22				
E	6.15 BSC						
E1	5.50	5.80	6.10				
E2	3.45		4.30				
е	1.27 BSC						
G	0.51	0.61	0.71				
K	1.20	1.35	1.50				
L	0.51	0.61	0.71				
L1	0.05	0.17	0.20				
M	3.00	3.40	3.80				
θ	0 °		12 °				

- STYLE 1: PIN 1. SOURCE
 - 2. SOURCE
 - 3. SOURCE GATE
- зх 4X <−0.750 8x b 0.10 C Α В .000 Ф e/2 0.05 C 0.965 Κ 1.330 0.905 2X F2 0.495 -PIN 5 (EXPOSED PAD) М 4.530 3.200 0.475 D2 G 2X **BOTTOM VIEW** → 1.530 4.560

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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